Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/510,945	SHIRAISHI, YASUHIRO	
Examiner	Art Unit	
Paul Kim	2857	

SEARCHED			
Class	Subclass	Date	Examiner
318	801 803	4/25/2005	PK
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702	61,64,65	4/26/2005	PK
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	H NOTES ARCH STRATEGY)
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ANJAN DEB	4/25/2005	PK
JIMMY NGUYEN	4/26/2005	PK
JEFF STERRETT	4/26/2005	PK
EAST	4/26/2005	PK